RENESAS

DATASHEET

ISL78420

100V, 2A Peak, Half-Bridge Driver with Tri-Level PWM Input and Adjustable Dead-Time

FN8296 Rev 4.00 September 29, 2016

The **ISL78420** is a 100V, 2A high frequency half-bridge NMOS FET driver with a tri-level PWM input. With an operating supply range of 8V to 14V and integrated high-side bootstrap bias, it supports driving the high-side and low-side NMOS in 100V halfbridge applications.

This driver is designed to work in conjunction with the [ISL78220](http://www.intersil.com/products/isl78220?utm_source=intersil&utm_medium=datasheet&utm_campaign=isl78420-ds-description) and [ISL78225](http://www.intersil.com/products/isl78225?utm_source=intersil&utm_medium=datasheet&utm_campaign=isl78420-ds-description) "Multi-Phase Interleaved Boost PWM Controller" and the [ISL78226](http://www.intersil.com/products/isl78226?utm_source=intersil&utm_medium=datasheet&utm_campaign=isl78420-ds-description) "6-Phase 12V/48V Bidirectional Synchronous PWM Controller". It can also be used in applications where a standard half-bridge driver is needed.

This driver has a programmable dead-time to ensure break-before-make operation between the high-side and lowside MOSFET. A resistor is used to set the dead-time from 35ns to 220ns.

The PWM pin's tri-level input allows control of the high-side and low-side drivers with a single pin. When the PWM input is at logic high, the high-side bridge FET is turned on and the lowside FET is off. When the input is at logic low, the low-side bridge FET is turned on and the high-side FET is turned off. When the input voltage is in mid-level state, both the high and low-side bridge FETs are turned off. The enable pin (EN), when low, also turns both bridge FETs off. This EN input can be used when the controller driving the ISL78420 does not utilize a trilevel output. Both PWM and EN logic inputs are V_{DD} tolerant.

The ISL78420 is offered in a 14 Ld HTSSOP package and complies with 100V conductor spacing per IPC-2221. The device is Automotive AEC-Q100 qualified for the temperature range of -40°C to +125°C.

Features

- 114VDC bootstrap supply maximum voltage
- 2A source and sink driver for 100V half-bridge NMOS FETs
- Programmable dead-time prevents shoot-through; adjustable from 35ns to 220ns with a single resistor
- Unique tri-level PWM input logic enables phase shedding when using multiphase PWM controllers (e.g. ISL78220/225/226)
- On-chip 1Ω (dynamic) bootstrap diode
- 10ns rise and fall times with 1000pF load
- 8V to 14V operating voltage range
- V_{DD} and Boostrap supply Undervoltage Lockout (UVLO)
- 14 Ld HTSSOP package compliant with 100V conductor spacing guidelines per IPC-2221
- **[AEC-Q100](http://www.intersil.com/en/products/end-market-specific/automotive-ics/aec-q100.html?)** qualified

Applications

- Automotive applications
- 12V/48V bi-directional converter (ISL78226)
- Multiphase boost (ISL78220/225)
- Class-D amplifiers

Related Literature

- For a full list of related documents, visit our web page
	- [ISL78420](http://www.intersil.com/products/isl78420?utm_source=intersil&utm_medium=datasheet&utm_campaign=isl78420-ds-references#documents) product page

FIGURE 1. NMOS DRIVER FOR 6-PHASE BIDIRECTIONAL BUCK AND BOOST CONVERTER

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Block Diagram

Pin Configurations

Pin Descriptions

Ordering Information

NOTES:

1. Add "-T" suffix for 2.5k unit or "-T7A" suffix for 250 unit tape and reel options. Refer to [TB347](http://www.intersil.com/content/dam/Intersil/documents/tb34/tb347.pdf) for details on reel specifications. .

2. These Intersil Pb-free plastic packaged products employ special Pb-free material sets, molding compounds/die attach materials, and 100% matte tin plate plus anneal (e3 termination finish, which is RoHS compliant and compatible with both SnPb and Pb-free soldering operations). Intersil Pb-free products are MSL classified at Pb-free peak reflow temperatures that meet or exceed the Pb-free requirements of IPC/JEDEC J STD-020.

3. For Moisture Sensitivity Level (MSL), please see device information page for **ISL78420**. For more information on MSL please see tech brief [TB363.](http://www.intersil.com/data/tb/tb363.pdf)

4. These packages meet compliance with 100V Conductor Spacing Guidelines per IPC-2221.

Absolute Maximum Ratings ([Note 5\)](#page-3-2) Thermal Information

Maximum Recommended Operating

Conditions [\(Note 5\)](#page-3-2)

CAUTION: Do not operate at or near the maximum ratings listed for extended periods of time. Exposure to such conditions may adversely impact product reliability and result in failures not covered by warranty.

NOTES:

- 5. All voltages referenced to V_{SS} unless otherwise specified.
- 6. The operating voltage from HB to GND is the sum of VDD and the HS voltage. The maximum operating voltage from HB to GND is recommended to be under 114V.
- 7. θ_{JA} is measured in free air with the component mounted on a high-effective thermal conductivity test board with "direct attach" features. See Tech Brief [TB379](http://www.intersil.com/data/tb/tb379.pdf).
- 8. For θ_{JC} , the "case temp" location is the center of the exposed metal pad on the package underside.
- 9. Specified at published junction to ambient thermal resistance for a junction temperature of 150°C. Refer to [Note 7](#page-3-0) for test condition to establish junction to ambient thermal resistance.

Electrical Specifications $V_{DD} = V_{HB} = EN = 12V$, $V_{SS} = V_{HS} = 0V$. No load on LO or HO, unless otherwise specified. Boldface limits apply across the operating temperature range, -40°C to +125°C.

Electrical Specifications $V_{DD} = V_{HB} = EN = 12V$, $V_{SS} = V_{HS} = 0V$. No load on LO or HO, unless otherwise specified. Boldface limits apply across the operating temperature range, -40°C to +125°C. (Continued)

Switching Specifications VDD = VHB = 12V, VSS = VHS = 0V, PWM = 0V to 12V, RDT = 8kΩ or 80kΩ. No Load on LO or HO, unless otherwise specified. Boldface limits apply across the operating temperature range, -40°C to +125°C.

NOTES:

10. Parameters with MIN and/or MAX limits are 100% tested at +25°C, unless otherwise specified. Temperature limits are established by characterization and are not production tested.

11. Dead Time is defined as the time between LO falling and HO rising or between HO falling and LO rising. See ["Timing Diagram"](#page-5-2) for measurement specification.

Timing Diagram

t_{DTHL}: Dead-Time Delay from HO falling to LO rising. Measured from 50% of HO to 50% of LO. t_{PLO}: Propagation Delay from PWM rising to LO falling. Measured from V_{MIDL} to 50% of LO. t_{PHO}: Propagation Delay from PWM falling to HO falling. Measured from V_{MIDH} to 50% of HO.

FIGURE 4. TIMING DIAGRAM

Typical Performance Curves Unless otherwise specified, operating conditions at: $T = +25^{\circ}$ C; V_{DD} = EN = 12V; V_{SS} = HS = 0V; Capacitor from HB to HS pin C_{BOOT} = 0.47μF; 100kΩ load on LO and HO to VSS.

FIGURE 9. PROPAGATION DELAYS vs TEMPERATURE FIGURE 10. DEAD-TIME DELAY VS RDT RESISTOR

FIGURE 5. I_{DD} OPERATING CURRENT vs FREQUENCY, R_{DT} = 8kΩ FIGURE 6. I_{DD} OPERATING CURRENT vs FREQUENCY, R_{DT} = 47kΩ

FIGURE 7. I_{HB} OPERATING CURRENT vs FREQUENCY, R_{DT} = 8kΩ FIGURE 8. I_{HB} OPERATING CURRENT vs FREQUENCY, R_{DT} = 47kΩ

Typical Performance Curves Unless otherwise specified, operating conditions at: T = +25°C; V_{DD} = EN = 12V;

V_{SS} = HS = 0V; Capacitor from HB to HS pin C_{BOOT} = 0.47μF; 100kΩ load on LO and HO to VSS. (ContInued)

FIGURE 11. HO and LO PIN OUTPUT IMPEDANCE vs TEMPERATURE FIGURE 12. BOOTSTRAP DIODE I-V CHARACTERISTICS

FIGURE 13. OUTPUT HIGH (VOH) VOLTAGE vs TEMPERATURE FIGURE 14. OUTPUT LOW (VOL) VOLTAGE vs TEMPERATURE

FIGURE 15. PEAK PULL-DOWN CURRENT VS OUTPUT VOLTAGE FIGURE 16. PEAK PULL-UP CURRENT VS OUTPUT VOLTAGE

Typical Performance Curves Unless otherwise specified, operating conditions at: $T = +25^{\circ}$ C; $V_{DD} = EN = 12V$; V_{SS} = HS = 0V; Capacitor from HB to HS pin C_{BOOT} = 0.47μF; 100kΩ load on LO and HO to VSS. (Continued)

FIGURE 21. I_{DD} QUIESCENT CURRENT vs SUPPLY VOLTAGE FIGURE 22. I_{HB} QUIESCENT CURRENT vs VOLTAGE

FIGURE 18. V_{HB} UNDERVOLTAGE LOCKOUT THRESHOLD vs TEMPERATURE

Functional Description

Gate Drive for NMOS Half-Bridge

The ISL78420 is a NMOS FET driver for up to 100V half-bridge configurations. In a half-bridge configuration the low-side FET source is connected to ground while the low-side FET drain and the high-side FET source are connected together to form the phase or switching node. The drain of the high-side FET is connected to the high voltage power supply.

The gate of the low-side FET requires a ground referenced drive signal to switch on and off. The signal needs to be above the gate threshold VGS of the FET. The gate drive of the high-side FET is more challenging and is what the ISL78420 is designed for. The high-side FET source is the phase node, which switches between ground and the high voltage supply connected to the high-side FET drain. The gate voltage needs to be above the source voltage by V_{GS} to turn on (the source can be as high as 100V). A bootstrap circuit is implemented to generate a bias voltage above the voltage seen at the phase node to drive the gate of the high-side FET.

Key properties of a half-bridge gate driver are:

- 1. Gate drive signals needs to be sufficiently higher than the V_{GS} specified in MOSFET datasheets for proper operation. For 60V to 100V NMOS FETs the gate threshold is in the range of 2V to 4V. For switching operation, the V_{GS} is typically specified in a range of 8V to 12V.
- 2. Gate drive signal needs to provide sufficient current to charge and discharge the dynamic gate capacitance of power MOSFETs in the target switching frequencies up to 1MHz. For 60V to 100V NMOS FETs, the typical gate charge can be as high as 80nC.

Functional Overview

The ISL78420 is a 100V, 2A high frequency half-bridge driver designed to deliver the fast gate charge needed to switch half-bridge configured NMOS FETs. The ISL78420 features a tri-level logic input to control the high- and low-side gate driver using only a single input pin. Typically, bridge drivers have independent inputs to add dead-time control. The ISL78420 also features a dead-time control allowing the user to program dead time from a range of 35ns to 220ns with a single resistor to ground.

A unique feature of the ISL78420 is the PWM pin's tri-level logic input. It allows control of the high-side and low-side drivers with a single pin. When the PWM input is at logic high, the high-side bridge FET is turned on and the low-side FET is off. When the input is at logic low, the low-side bridge FET is turned on and the high-side FET is turned off. When the input voltage is in tri-level state, both the high and low-side bridge FETs are turned off. This driver is designed to work in conjunction with the **[ISL78220](http://www.intersil.com/products/isl78220?utm_source=intersil&utm_medium=datasheet&utm_campaign=isl78420-ds-description)** and [ISL78225](http://www.intersil.com/products/isl78225?utm_source=intersil&utm_medium=datasheet&utm_campaign=isl78420-ds-description) "Multi-Phase Interleaved Boost PWM Controller" and the **[ISL78226](http://www.intersil.com/products/isl78226?utm_source=intersil&utm_medium=datasheet&utm_campaign=isl78420-ds-description)** "6-Phase 12V/48V Bidirectional Synchronous PWM Controller". The enable pin (EN) when low turns both bridge FETs off. The EN input is used when the interfacing controller does not utilize a tri-level output. Both PWM and EN logic inputs are V_{DD} tolerant.

The ISL78420 high-side driver bias is established by the internal boot diode and the external boot capacitor connected between the HB and HS pins. The charge on the boot capacitor is provided by the internal boot diode that is connected from VDD to HB (referred to as boot refresh). The current path to charge the boot capacitor occurs when the low-side bridge FET is on, which takes the phase node (HS pin) to ground. The charge current is limited in amplitude by the internal resistance of the boot diode and the low-side FET $r_{DS(ON)}$. Assuming that the on time of the low-side FET is sufficiently long to fully charge the boot capacitor, the boot voltage on the HB pin (V_{HB}) will charge to VDD minus the boot diode drop and the on-voltage of the low-side bridge FET.

When the PWM input transitions high, the high-side bridge FET is driven on after the low-side FET is turned off. The HS node is connected to the source of the high-side FET and the HS node will rise almost to the level of the bridge voltage V_{BRIDGE} (minus the on-voltage drop across the high-side FET). The boot capacitor voltage is referenced to the source voltage of the high-side FET so the V $_{HB}$ voltage is approximately V $_{DD}$ volts above the HS node and the boot diode is reversed biased by V_{BRIDGE} . Because the high-side driver circuit is referenced to the HS node, the HO output is now approximately $V_{HB} + V_{BRIDGE}$ above ground. More importantly, the HO gate drive is approximately V_{DD} above the HS node to provide the proper V_{GS} to turn on the high-side FET.

During the low-to-high transition of the HS node, the boot capacitor supplies the necessary charge current to fully turn on the high-side FET gate. After the gate is fully charged, the boot capacitor voltage continues to provide bias to the high-side gate to keep the FET on. The stored charge of the boot capacitor must be substantially larger than the required gate charge of the high-side FET and the bias current of the high-side driver otherwise the boot voltage will sag excessively. If the boot capacitor value is too small for the required on-time of the high-side FET, causing the boot voltage to drop below the high-side bias HB pin UVLO falling threshold (6.3V typical), the high-side driver is disabled resulting in undesireable operation. See ["Selecting the Boot Capacitor Value"](#page-9-0) for choosing the proper capacitor value.

Application Information

Selecting the Boot Capacitor Value

The boot capacitor value is chosen not only to supply the internal bias current of the high-side driver but also, and more significantly, to provide the gate charge of the high-side driven FET without causing the boot voltage to sag excessively. As good practice, the boot capacitor should have a total charge that is 10x to 20x the gate charge of the power FET to achieve a 5% to 10% drop in voltage after the charge has been transferred from the boot capacitor to the gate capacitance. The high-side driver bias voltage is V_{DD} - VF where VF is the voltage drop of the boot diode. If the boot voltage (HB - HS) is allowed to drop below the HB UVLO falling threshold (6.3V typical) this will disable the high-side driver.

The boot capacitor is discharged by three means:

- 1. The bias current of the high-side gate driver.
- 2. Current flowing through the resistor across the gate-to-source of the high-side FET.
- 3. Gate current when the high-side FET is turned ON.

The boot capacitor is recharged through the boot diode internal to the ISL78420 during the time the low-side FET turns on, taking the HS pin to ground. The ISL78420's internal boot diode has a typical dynamic impedance of 0.8Ω, which recharges the boot capacitor quickly. The low dynamic impedance allows the ISL78420 to drive the high frequency half-bridge, depending on the boot capacitor value used.

The following parameters are required to calculate the value of the boot capacitor for a specific amount of voltage droop. In this example, the values used are arbitrary. They should be changed to comply with the actual application.

FIGURE 23. TYPICAL GATE CHARGE OF A POWER NMOS FET

The following equations calculate the total charge required for one switching cycle of the high-side FET. These equations assume that all of the parameters are constant during the period duration. The error is insignificant if the ripple voltage allowed is small (5% or less as specified above).

$$
Q_C = Q_{gate} + Period \times (I_{HB} + V_{HO}/R_{GS} + I_{gate_leak})
$$
 (EQ. 1)

$$
C_{\text{boot}} = Q_{\text{C}} / (\text{Ripple*VDD})
$$
\n
$$
C_{\text{boot}} = 0.57 \mu \text{F}
$$
\n(EQ. 2)

If the gate-to-source resistor is removed (R_{GS} is usually not needed) then:

 $C_{boot} = 0.38\,\text{µF}$

Input Capacitor

The input capacitor to the VDD pin serves two main purposes. It provides AC decoupling and transient current for the dynamic switching of the high and low-side gate drivers of the ISL78420. The second and more critical function is to provide the gate charge to the low-side driven FET while keeping the VDD voltage ripple to a minimum, similar to the function of the boot capacitor. Improper input capacitance may cause excessive ripple on VDD that triggers the UVLO falling threshold (6.7V typical), disabling the driver. The minimum input capacitance required for the low-side gate charge while maintaining an allowed ripple on VDD is calculated similarly as the boot capacitor described in the previous section. To account for the increased current of I_{DD} vs I_{HB} , it is recommended to have the input capacitance be at minimum 10x of the boot capacitor value. In addition, a 0.1µF capacitor in parallel is recommended for high frequency decoupling. For optimal performance, place these capacitors close to the VDD and VSS pins.

Dead-Time Delay

When the PWM input transitions high or low, it is necessary to ensure that both bridge FETs are not on at the same time to prevent shoot-through currents. The ISL78420 programmable timers delay the rising edge of the high-side (HO) and low-side (LO) gate drives so that both FETs are off before one of them is turned on. The dead-time delay on the rising edge of LO and HO is programmable with a single resistor from the RDT pin to V_{SS} . The dead time is adjustable from 35ns (R_{RDT} = 80kΩ) to 220ns $(R_{RDT} = 8k Ω). It is not recommended to use resistors beyond$ these values. The dead time is set equal on both falling edges of LO and HO. See ["Timing Diagram" on page 6](#page-5-2) for the definition of dead-time delay. See **[Figure 10 on page 7](#page-6-0)** for the programmed dead time vs resistor value.

While the voltage of the PWM signal is within the boundaries of the mid-level logic (1.6V to 3.4V typical), the HO and LO pins are driven low (with respect to VSS for LO pin and with respect to HS for HO pin). The actual delay time, as programmed by the R_{RDT} resistor value, begins when the high or low logic threshold levels at the PWM input are crossed. The time when the PWM input is in the mid-level range is added to the programmed dead time. This should be a consideration when selecting the R_{RDT} value for a specific dead time.

Typical Application Circuit

Depending on the application, the switching speed of the bridge FETs can be reduced by adding series connected resistors between the HO output and the FET gate. Gate-to-source resistors are recommended on the low-side FETs to prevent unexpected turn-on of the bridge should the bridge voltage be applied before VDD. Gate-to-source resistors on the high-side FETs are not usually required if low-side gate-to-source resistors are used. If relatively low value gate-to-source resistors are used on the high-side FETs, be aware that a larger value for the boot capacitor may be required.

Transients on HS Node

forward topology.

An important operating condition that is occasionally overlooked by designers is the negative transient on the HS pin that can occur when the high-side bridge FET turns off. The maximum transient allowed on the HS pin is -5V but it is wise to minimize the amplitude to lower levels. This transient is the result of the parasitic inductance of the low-side drain-source conductor on the PCB. Even the parasitic inductance of the low-side FET contributes to this transient.

When the high-side bridge FET turns off (see [Figure 25\)](#page-11-0), because of the load inductive characteristics, the current that was flowing in the high-side FET (blue) must rapidly commutate to flow through the low-side FET (red). The amplitude of the negative transient impressed on the HS node is (L*di/dt) where L is the total parasitic inductance of the low-side FET drain-to-source path and di/dt is the rate at which the high-side FET is turned off. With the increasing power levels of power supplies and motors, clamping this transient becomes significant for the proper operation of the ISL78420.

In the event that the negative transient exceeds -5V, there are several ways of reducing the negative amplitude of this transient. If the bridge FETs are turned off more slowly to reduce di/dt, the amplitude will be reduced but at the expense of more switching

losses in the FETs. Careful PCB design will also reduce the value of the parasitic inductance. However, in extreme cases, these two solutions by themselves may not be sufficient. [Figure 25](#page-11-0) illustrates a simple method for clamping the negative transient. Two series connected, fast 1 amp PN junction diodes are connected between HS and VSS as shown. It is important that these diodes be placed as close as possible to the HS and VSS pins to minimize the parasitic inductance of this current path between the two pins. Two diodes in series are required because they are in parallel with the body diode of the low-side FET. If only one diode is used for the clamp, it will conduct some of the negative load current that is flowing in the body diode of the low-side FET.

FIGURE 25. TWO CLAMPING DIODES TO SUPPRESS NEGATIVE TRANSIENTS

An alternative to the two series connected diodes is one diode and a resistor, (see **Figure 26**). In this case, it is necessary to limit the current in the diode with a small value resistor, R_{H_S} , connected between the phase node of the 1/2 bridge and the HS pin. Observe that R_{HS} is effectively in series with the HO output and serves as a peak current limiting gate resistor on HO.

FIGURE 26. RESISTOR AND DIODE NEGATIVE TRANSIENT CLAMP

The value of R_{HS} is determined by how much average current in the clamping diode is acceptable. Current in the low-side FET flows through the body diode during dead time resulting with a negative voltage on HS that is typically about -1.5V. When the low-side FET is turned on, the current through the body diode is shunted away into the channel and the conduction voltage from source-to-drain is typically much less than the conduction voltage through the body diode. Consequently, significant current will flow in the clamping diode only during the dead time. Because the dead time is much less than the on time of the low-side FET, the resulting average current in the clamping diode is very low. The value of R_{HS} is then chosen to limit the peak current in the clamping diode and usually just a few ohms is necessary.

Please note that a similar transient with a positive polarity occurs when the low-side FET turns off. This is less frequently a problem because the HS node is floating up toward the bridge bias voltage. The Absolute Max voltage rating for the HS node does need to be observed when the positive transient occurs.

The maximum rating for V_{HB} - V_{HS} = 14V must also not be overlooked. When a negative transient, Vneg, is present on the HS pin, the voltage differential across HB and HS will approach VDD + Vneg. If the transient duration is short compared to the charging time constant of the boot diode and boot capacitor, the voltage across HB and HS is not significantly affected. However, another source of negative voltage on the HS pin may increase the boot capacitor voltage for a longer duration. During dead time, current is flowing from the source-to-drain of the low-side FET body diode. Depending on the size of the FET and the amplitude of the reverse current, the voltage across the diode can be as high as -1.5V and much higher during a load fault. Because this negative voltage has little impedance, the boot capacitor can charge to a voltage greater than VDD (for example VDD + 1.5V). It may be necessary to either clamp the voltage as described in **Figures 25** and [26](#page-12-0) and/or keep the dead time as short as possible.

Power Dissipation

The power dissipation of the ISL78420 is dominated by the gate charge required by the driven bridge FETs and the switching frequency. The internal bias and boot diode also contribute to the total dissipation but these losses are usually less significant compared to the gate charge losses.

The calculation of the power dissipation of the ISL78420 is approximated by the following equations:

GATE POWER (FOR THE HO AND LO OUTPUTS)

$$
P_{gate} = (Q_{gateH} + Q_{gateL}) \times Freq \times VDD
$$
 (EQ. 3)

where Q_{gateH} and Q_{gateL} is the total gate charge of the high-side and low-side bridge FET respectively. VDD is the bias to the ISL78420 and Freq is the switching frequency.

BOOT DIODE DISSIPATION

$$
I_{\text{diode_avg}} = Q_{\text{gate}} \times \text{Freq}
$$
 (EQ. 4)

$$
P_{\text{diode}} = I_{\text{diode_avg}} \times 0.7V \tag{EQ.5}
$$

where 0.7V is the diode conduction voltage. **Equations 4** and 5 represent the boot diode conduction loss from recharging the boot capacitor during the refresh cycle. The average current is proportional to the total charge delivered to the high-side NFET and the switching frequency.

BIAS CURRENT

$$
P_{bias} = I_{bias} \times VDD
$$
 (EQ. 6)

where I_{bias} is the internal bias current of the ISL78420 at the switching frequency (see [Figures 5](#page-6-1) and [6](#page-6-2)).

TOTAL POWER DISSIPATION

 $P_{total} = P_{gate} + P_{diode} + P_{bias}$

JUNCTION OPERATING TEMPERATURE

$$
T_{J} = P_{total} \times \theta_{JA} + T_{A}
$$

where T_J is the junction temperature at the operating ambient temperature, T_A , in the vicinity of the part.

$$
T_J = P_{total} \times \theta_{JC} + T_{PCB}
$$

where $T₁$ is the junction temperature with the operating temperature of the PCB, T_{PCB} , as measured where the EPAD is soldered.

High Voltage Conductor Spacing

The HTSSOP package adheres to IPC-2221 guidelines for high voltage conductor spacing of external component leads. The required pin-to-pin spacing for 100V conductors is 0.5mm for nonconformal coat PCB boards. For the ISL78420 14 Ld HTSSOP package, the high voltage pins are separated from the low voltage pins across the 4.4mm wide package. While the HB, HO, and HS pins are grouped together and can swing from 0V to 114V, under normal operation the maximum differential voltage across these pins is limited by the VDD supply (14V Max Operating).

PC Board Layout

The AC performance of the ISL78420 depends significantly on the design of the PC board. The following layout design guidelines are recommended to achieve optimum performance from the ISL78420:

- Understand how power currents flow. The high amplitude di/dt currents of the bridge FETs will induce significant voltage transients on the associated traces.
- Keep power loops as short as possible by paralleling the source and return traces.
- Avoid paralleling high di/dt traces with low level signal lines. High di/dt will induce currents in the low level signal lines.
- When practical, minimize impedances in low level signal circuits; the noise, magnetically induced on a 10k resistor, is 10x larger than the noise on a 1k resistor.
- Be aware of magnetic fields emanating from transformers and inductors. Core gaps in these structures are especially bad for emitting flux.
- If you must have traces close to magnetic devices, align the traces so that they are parallel to the flux lines.
- The use of low inductance components such as chip resistors and chip capacitors is recommended.
- Use decoupling capacitors to reduce the influence of parasitic inductors. To be effective, these capacitors must also have the shortest possible lead lengths. If vias are used, connect several paralleled vias to reduce the inductance of the vias.
- It may be necessary to add resistance to dampen resonating parasitic circuits. In PCB designs with long leads on the LO and HO outputs, it may be necessary to add series gate resistors on the bridge FETs to dampen the oscillations.
- Keep high dv/dt nodes away from low level circuits. Guard banding can be used to shunt away dv/dt injected currents from sensitive circuits. This is especially true for the PWM control circuits.
- Avoid having a signal ground plane under a high dv/dt circuit. This will inject high di/dt currents into the signal ground paths.
- Do power dissipation and voltage drop calculations of the power traces. Most PCB/CAD programs have built in tools for calculation of trace resistance.
- Large power components (Power FETs, Electrolytic capacitors, power resistors, etc.) will have internal parasitic inductance, which cannot be eliminated. This must be accounted for in the PCB layout and circuit design.
- If you simulate your circuits, consider including parasitic components.

EPAD Design Considerations

The thermal pad of the ISL78420 is electrically isolated. Its primary function is to provide heat sinking for the IC. It is recommended to tie the EPAD to VSS (GND).

[Figure 27](#page-13-0) is an example of how to use vias to remove heat from the IC substrate. Depending on the amount of power dissipated by the ISL78420, it may be necessary to connect the EPAD to one or more ground plane layers. A via array, within the area of the EPAD, will conduct heat from the EPAD to the ground plane on the bottom layer. If inner PCB layers are available, it would also be desirable to connect these additional layers with the plated-through vias.

The number of vias and the size of the GND planes required for adequate heat-sinking is determined by the power dissipated by the ISL78420, the air flow, and the maximum temperature of the air around the IC.

It is important that the vias have a low thermal resistance for efficient heat transfer. Do not use "thermal relief" patterns to connect the vias.

FIGURE 27. RECOMMENDED PCB HEATSINK

Revision History The revision history provided is for informational purposes only and is believed to be accurate, but not warranted. Please visit our website to make sure you have the latest revision.

Revision History The revision history provided is for informational purposes only and is believed to be accurate, but not warranted. Please visit our website to make sure you have the latest revision. (Continued)

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September 29, 2016

Package Outline Drawing

L10.4x4

10 LEAD THIN DUAL FLAT NO-LEAD PLASTIC PACKAGE Rev 2, 4/15

TOP VIEW

3.2 REF B b b 8X 0.80 BSC **5 1** \mathbf{I} **10X 0 . 40** Π \mathbf{I} **10 6 0.10 M**
0.05 MC 0.10(M)C | A B **10 X 0.30 4 3.00**

BOTTOM VIEW

DETAIL "X"

NOTES:

- **Dimensions in () for Reference Only. 1. Dimensions are in millimeters.**
- **Dimensioning and tolerancing conform to AMSE Y14.5m-1994. 2.**
- **Unless otherwise specified, tolerance : Decimal ± 0.05 3.**
- **between 0.15mm and 0.30mm from the terminal tip. Dimension b applies to the metallized terminal and is measured 4.**
- **5. Tiebar shown (if present) is a non-functional feature and may be located on any of the 4 sides (or ends).**
- **located within the zone indicated. The pin #1 identifier may be The configuration of the pin #1 identifier is optional, but must be 6. either a mold or mark feature.**

Package Outline Drawing

For the most recent package outline drawing, see [M14.173B](http://www.intersil.com/content/dam/intersil/documents/M14_/m14.173b.pdf)

M14.173B

14 LEAD HEAT-SINK THIN SHRINK SMALL OUTLINE PACKAGE (HTSSOP) Rev 1, 1/10

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Наши преимущества:

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- Поставка более 17-ти миллионов наименований электронных компонентов;
- Поставка сложных, дефицитных, либо снятых с производства позиций;
- Оперативные сроки поставки под заказ (от 5 рабочих дней);
- Экспресс доставка в любую точку России;
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- Система менеджмента качества сертифицирована по Международному стандарту ISO 9001;
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- Подбор аналогов;
- Консультации по применению компонента;
- Поставка образцов и прототипов;
- Техническая поддержка проекта;
- Защита от снятия компонента с производства.

Как с нами связаться

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